

Notic of Referenc s Cited	Application/Control No. 10/024,892	Applicant(s)/Patent Under Reexamination KIM, JONG HEON	
	Examiner Christopher W Lattin	Art Unit 2812	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-US006413868B1	07-2002	Bartush et al.	438/690
	C	US-US 20020140069A1	10-2002	Lee et al.	257/678
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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